

## OptiMOS<sup>™</sup>-5 Power Transistor





#### **Features**

- OptiMOS™ power MOSFET for automotive applications
- N-channel Enhancement mode Normal level
- MSL1 up to 260°C peak reflow
- 175 °C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

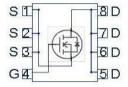
#### **Product Summary**

$V_{\mathrm{DS}}$	60	<b>V</b>
$R_{\mathrm{DS(on),max}}$	5	mΩ
I <sub>D</sub>	40	Α

#### PG-TSDSON-8-33



Туре	Package	Marking
IAUZ40N06S5N050	PG-TSDSON-8-33	5N06050



#### Maximum ratings, at $T_i$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Drain current	I <sub>D</sub>	V <sub>GS</sub> =10 V, Chip limitation <sup>1,2)</sup>	86	А
		V <sub>GS</sub> =10V, DC current <sup>3)</sup>	40	
		$T_{\rm a}$ =85 °C, $V_{\rm GS}$ =10 V, $R_{\rm thJA}$ on 2s2p <sup>2,4)</sup>	14	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	$T_{\rm C}$ =25 °C, $t_{\rm p}$ = 100 μs	241	
Avalanche energy, single pulse <sup>2)</sup>	E <sub>AS</sub>	I <sub>D</sub> =20 A	115	mJ
Avalanche current, single pulse	I <sub>AS</sub>	-	40	Α
Gate source voltage	$V_{GS}$	-	±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	71	W
Operating and storage temperature	$T_{\rm j},T_{\rm stg}$	-	-55 <b>+</b> 175	°C



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics <sup>2)</sup>						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$	-	-	-	2.1	K/W
Thermal resistance, junction - ambient <sup>4)</sup>	$R_{thJA}$	-	-	35.5	-	

**Electrical characteristics,** at  $T_j$ =25 °C, unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ =0V, $I_D$ =1mA	60	ı	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=29\mu{\rm A}$	2.2	2.8	3.4	
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{\rm DS}$ =60V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =25°C	-	1	1	μΑ
		$V_{\rm DS}$ =60V, $V_{\rm GS}$ =0V, $T_{\rm j}$ =125°C <sup>1)</sup>	-	-	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	-	100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =7V, I <sub>D</sub> =10A	-	5.0	6.0	mΩ
		V <sub>GS</sub> =10V, I <sub>D</sub> =20A	-	4.0	5.0	
Gate resistance <sup>2)</sup>	$R_{G}$	-	-	1.5	-	Ω



Parameter	Symbol Conditions	Values			Unit	
			min.	typ.	max.	
Dynamic characteristics <sup>2)</sup>						
Input capacitance	Ciss		-	1692	2200	pF
Output capacitance	Coss	$V_{\rm GS}$ =0V, $V_{\rm DS}$ =30V, $f$ =1MHz	-	373	485	1
Reverse transfer capacitance	C <sub>rss</sub>		-	18	26	
Turn-on delay time	$t_{d(on)}$		-	3.8	-	ns
Turn-off delay time	$t_{d(off)}$	V <sub>DD</sub> =30V, V <sub>GS</sub> =10V,	-	8.9	-	
Rise time	t <sub>r</sub>	$I_{\rm D}$ =20A, $R_{\rm G,ext}$ =3.5 $\Omega$	-	1.0	-	
Fall time	$t_{f}$	]	-	4.6	-	
Gate Charge Characteristics <sup>2)</sup>	_	T		Ι		
Gate to source charge	Q <sub>gs</sub>		-	7.7	10.0	nC
Gate to drain charge	$Q_{gd}$	$V_{\rm DD}$ =30V, $I_{\rm D}$ =20A, $V_{\rm GS}$ =0 to 10V	-	4.4	6.6	
Gate charge total	Qg		ı	23.5	30.5	
Gate plateau voltage	V <sub>plateau</sub>		-	4.5	-	V
Reverse Diode						
Diode continous forward current <sup>2)</sup>	Is	T <sub>C</sub> =25°C	-	-	40	А
Diode pulse current <sup>2)</sup>	I <sub>S,pulse</sub>	$T_{\rm C}$ =25 °C, $t_{\rm p}$ = 100 μs	1	-	241	
Diode forward voltage	$V_{\mathrm{SD}}$	V <sub>GS</sub> =0V, I <sub>F</sub> =20A, T <sub>j</sub> =25°C	-	0.8	1.1	V
Reverse recovery time <sup>2)</sup>	t <sub>rr</sub>	V <sub>R</sub> =30V, I <sub>F</sub> =40A,	-	30	-	ns
Reverse recovery charge <sup>2)</sup>	Q <sub>rr</sub>	$di_F/dt=100A/\mu s$	-	22	-	nC

<sup>1)</sup> Practically the current is limited by the overall system design including the customer-specific PCB.

<sup>&</sup>lt;sup>2)</sup> The parameter is not subject to production test - verified by design/characterization.

<sup>&</sup>lt;sup>3)</sup> The product can operate at a specified current based on best practice to minimze electromigration at the solder joint. For rare events and inrush currents, the value may be exceeded.

<sup>&</sup>lt;sup>4)</sup> Device on a four-layer 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5-7). PCB is vertical in still air.



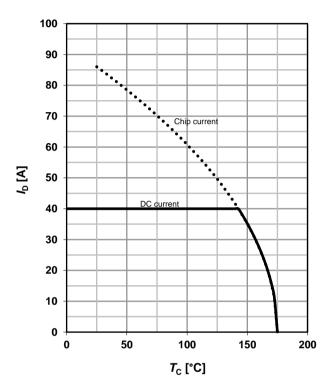
#### 1 Power dissipation

$$P_{\text{tot}} = f(T_{\text{C}}); V_{\text{GS}} = 10 \text{ V}$$

# 80 60 20 20 0 50 100 150 200 T<sub>C</sub> [°C]

#### 2 Drain current

$$I_{\rm D} = f(T_{\rm C}); \ V_{\rm GS} = 10 \ {\rm V}$$



#### 3 Safe operating area

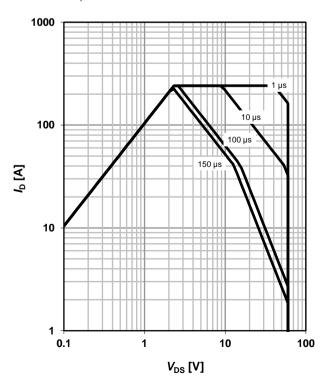
$$I_D = f(V_{DS}); T_C = 25 \text{ °C}; D = 0$$

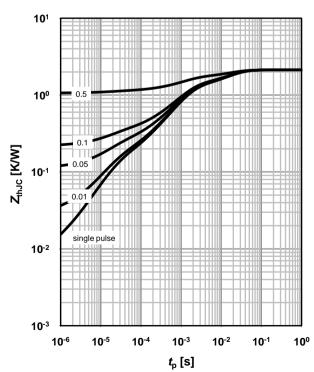
parameter:  $t_p$ 

#### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_{p})$$

parameter:  $D=t_p/T$ 







#### 5 Typ. output characteristics

 $I_{\rm D} = f(V_{\rm DS}); T_{\rm j} = 25 \,{}^{\circ}{\rm C}$ 

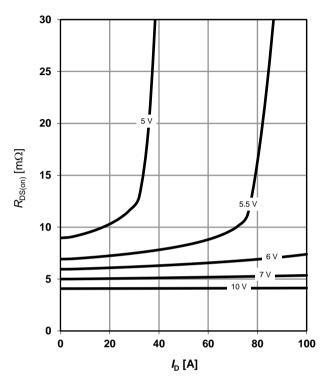
parameter: V<sub>GS</sub>

# 200 160 120 80 40 0 0 1 2 3 4 5 6 V<sub>DS</sub> [V]

#### 6 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(I_D); T_j = 25 \text{ °C}$ 

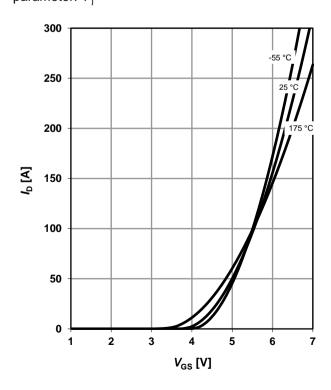
parameter: V<sub>GS</sub>



#### 7 Typ. transfer characteristics

 $I_D = f(V_{GS}); V_{DS} = 6V$ 

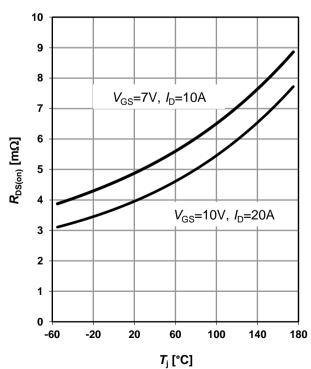
parameter:  $T_{\rm j}$ 



#### 8 Typ. drain-source on-state resistance

 $R_{DS(on)} = f(T_j);$ 

parameter: I<sub>D,</sub> V<sub>GS</sub>





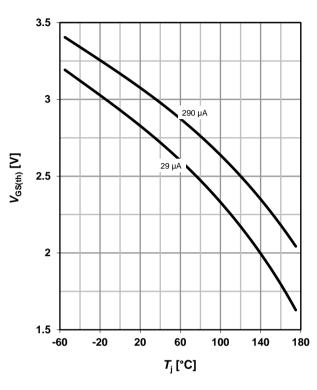
#### 9 Typ. gate threshold voltage

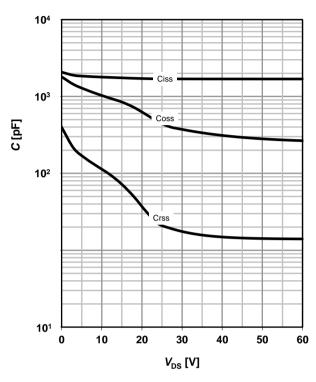
 $V_{GS(th)} = f(T_i); V_{GS} = V_{DS}$ 

parameter: I<sub>D</sub>

#### 10 Typ. capacitances

 $C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$ 





#### 11 Typical forward diode characteristics

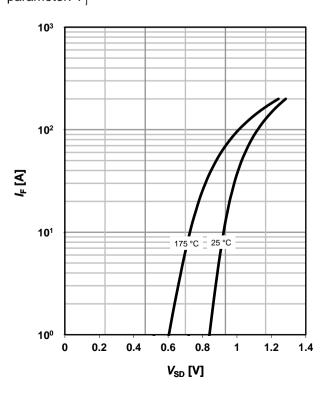
 $I_F = f(V_{SD})$ 

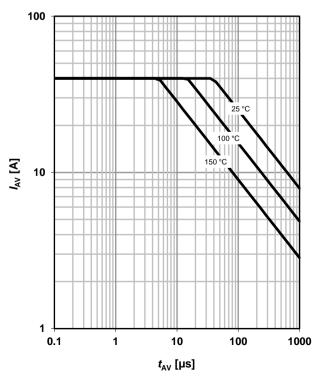
parameter:  $T_{\rm j}$ 

#### 12 Avalanche characteristics

 $I_{AS} = f(t_{AV})$ 

parameter: T<sub>i(start)</sub>







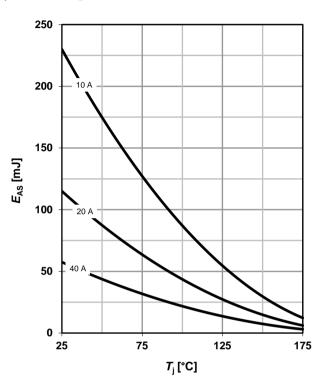
#### 13 Avalanche energy

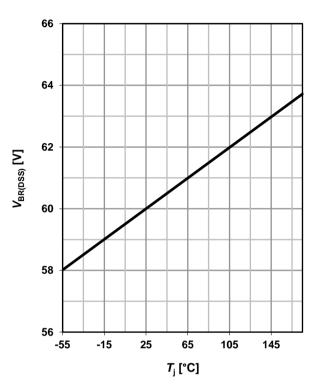
 $E_{AS} = f(T_i)$ 

parameter: I<sub>D</sub>

#### 14 Drain-source breakdown voltage

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$

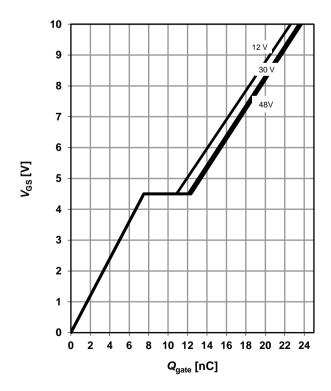




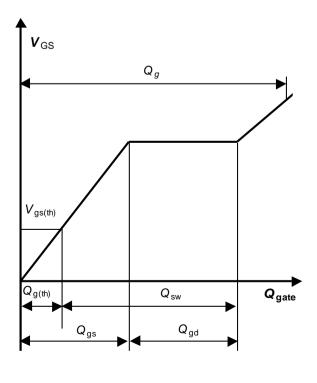
#### 15 Typ. gate charge

 $V_{GS} = f(Q_{gate}); I_D = 20 A pulsed$ 

parameter: V<sub>DD</sub>

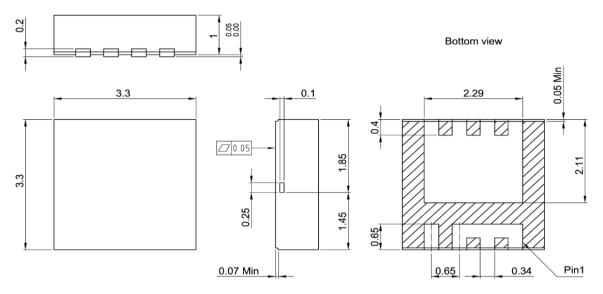


#### 16 Gate charge waveforms

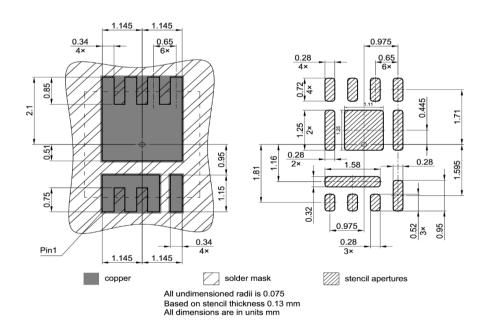




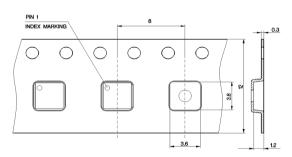
#### **Package Outline**



#### **Footprint**



#### **Packaging**





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#### **Revision History**

Version	Date	Changes
Revision 1.0	05.05.2020	Final Data Sheet
Revision 1.1	18.03.2021	Modified package outline and footprint

## **Mouser Electronics**

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